

P-Channel MOSFET

Features:

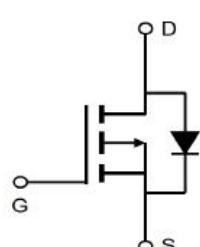
- ◆ RoHS Compliant
- ◆ Low ON Resistance
- ◆ Low Input Capacitance
- ◆ Low Miller Charge
- ◆ Low Input/Output Leakage

Applications:

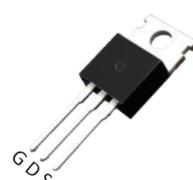
- Lithium - Ion Secondary Batteries
Load Switch
DC-DC converters and Off line UPS

$V_{DSS}(\text{Min.})$	-30 V
$R_{DS(\text{ON})}(\text{Typ.})$	16mΩ
I_D	-9 A

Schematic and Package Information:



PDFN5*6
CTG18P03A



TO-220CB
CTP18P03A



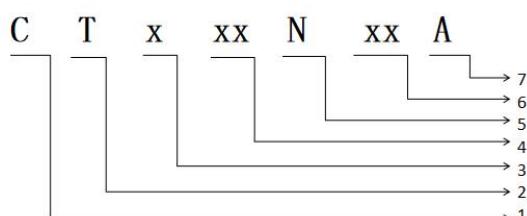
TO-252
CTD18P03A



PDFN3.3*3.3
CTK18P03A

Marking on the body:

MV/LV MOSFET tube naming rules



- 1: CYS for short
- 2: T: Trench S: SGT
- 3: Package

F: TO-220F	P: TO-220	D: TO-252
U: TO-251	W: TO-247S/3P	E: SOP-8
G: DFN5*6	K: DFN3.3*3.3	
- 4: RDS(on) Typ
- 5: N: N channel P: P channel
- 6: Maximum breakdown voltage (10% of BVdss)
- 7: Series no.

Absolute Maximum Ratings

$T_C=25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	CTx18P03A				Units
		PDFN 5*6	TO- 220CB	TO- 252	PDFN 3.3*3.3	
Drain-to-Source Voltage	V_{DSS}			-30		V
Gate-to-Source Voltage	V_{GS}			± 20		V
Continuous Drain Current	I_D			-9		A
Pulsed Drain Current, $V_{GS}@10\text{V}$ (NOTE *1)	I_{DM}			-120		A
Power Dissipation	P_D			60		W
Derating Factor above 25°C				10		
Single Pulse Avalanche Energy (L=0.5mH)	E_{AS}			60		mJ
Peak Diode Recovery dv/dt	dv/dt			5		V/ns
Maximum Temperature for Soldering	T_L			300		°C
Operating Junction and Storage Temperature Range (NOTE *2)	T_J and T_{STG}			150, -55 to 175		

Thermal Resistance

Parameter	Symbol	Typ.				Units	
		PDFN5*6	TO-220CB	TO-252	PDFN3.3*3.3		
Junction to Case	$R_{\theta JC}$	2.5			$^{\circ}\text{C}/\text{W}$		
Junction to Ambient	$R_{\theta JA}$	60			$^{\circ}\text{C}/\text{W}$		

Electrical Characteristics $T_J=25^{\circ}\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Drain-to-Source Breakdown Voltage	BV_{DSS}	-30	--	--	V	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=-250\mu\text{A}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{TH})}$	-1.0	-1.8	-2.5	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=-250\mu\text{A}$
Static Drain-to-Source On-Resistance	$\text{R}_{\text{DS}(\text{ON})}$	--	16	18	$\text{m}\Omega$	$\text{V}_{\text{GS}}=-10\text{V}, \text{I}_D=-1\text{A}$
Drain-to-Source Leakage Current	I_{DSS}	--	--	1	uA	$\text{V}_{\text{DS}}=-30\text{V}, \text{V}_{\text{GS}}=0\text{V}$ $T_J=25^{\circ}\text{C}$
		--	--	100		$\text{V}_{\text{DS}}=-30\text{V}, \text{V}_{\text{GS}}=0\text{V}$ $T_J=125^{\circ}\text{C}$
Gate-to-Source Forward Leakage	I_{GSS}	--	--	+100	nA	$\text{V}_{\text{GS}}=+20\text{V}$
Gate-to-Source Reverse Leakage		--	--	-100		$\text{V}_{\text{GS}}= -20\text{V}$

Dynamic Characteristics Essentially independent of operating temperature

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Input Capacitance	C_{iss}	--	2087	--	pF	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=-15\text{V}$ $f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	--	236	--		
Reverse Transfer Capacitance	C_{rss}	--	216	--		
Total Gate Charge	Q_g	--	41	--	nC	$\text{I}_D=-9\text{A}, \text{V}_D=-15\text{V}$ $\text{V}_{\text{GS}} = -10\text{V}$
Gate-to-Source Charge	Q_{gs}	--	9	--		
Gate-to-Drain ("Miller") Charge	Q_{gd}	--	6	--		
Turn-on Delay Time	$t_{\text{d}(\text{ON})}$	--	10	--		
Rise Time	t_{rise}	--	15	--	ns	$\text{V}_D=-15\text{V}, \text{I}_D=-9\text{A},$ $\text{V}_{\text{G}}=-10\text{V} \text{ R}_{\text{G}}=2.5\Omega$
Turn-Off Delay Time	$t_{\text{d}(\text{OFF})}$	--	50	--		
Fall Time	T_{fall}	--	20	--		

Source-Drain Diode Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Continuous Drain-Source Diode Forward Current	I_S	--	--	-9	A	$T_C=25^{\circ}\text{C}$
Pulsed Drain-Source Diode Forward Current	I_{SM}	--	--	-36		
Diode Forward Voltage	V_{SD}	--	--	-1.2	V	$I_{\text{SD}}=-15\text{A}, \text{V}_{\text{GS}}=0\text{V}$ $I_F = I_S$ $dI/dt=100\text{A/us}$
Reverse Recovery Time	t_{rr}	--	24	--		
Reverse Recovery Charge	Q_{rr}	--	16	--		

Notes:

1. $T_J = +25^{\circ}\text{C}$ to $+150^{\circ}\text{C}$.
2. Repetitive rating; pulse width limited by maximum junction temperature.
3. Pulse width < 300 μs ; duty cycle < 2%.

Typical Characteristics

Figure 1. Output Characteristics

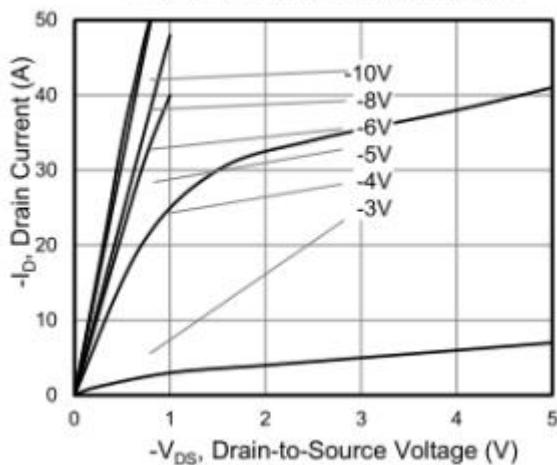


Figure 2. Transfer Characteristics

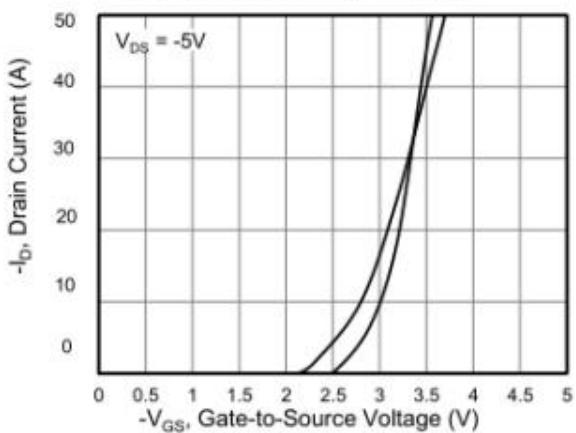


Figure 3. On-Resistance vs. Drain Current

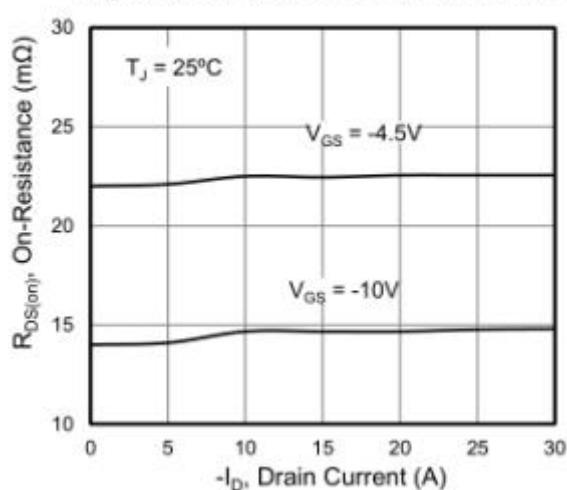


Figure 4. Capacitance

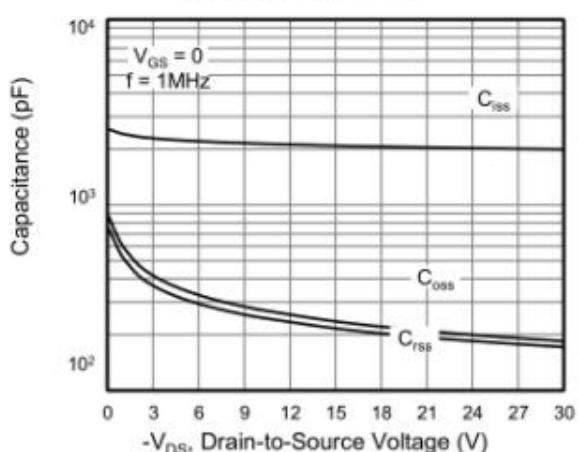


Figure 5. Gate Charge

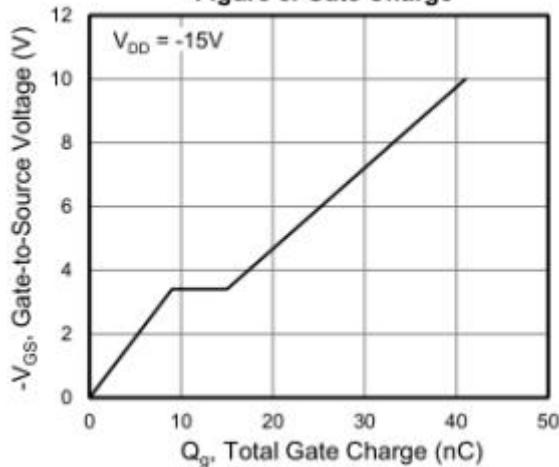


Figure 6. Body Diode Forward Voltage

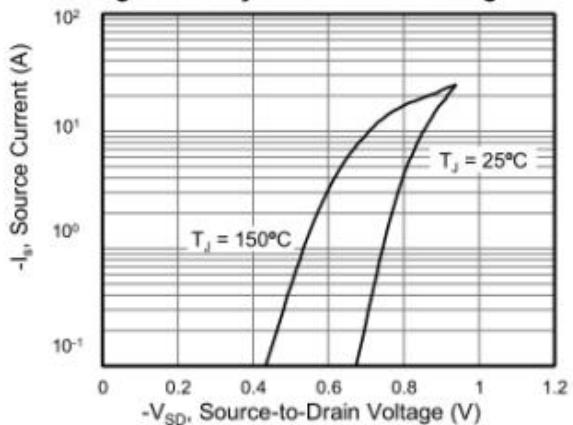


Figure 7. On-Resistance vs. Junction Temperature

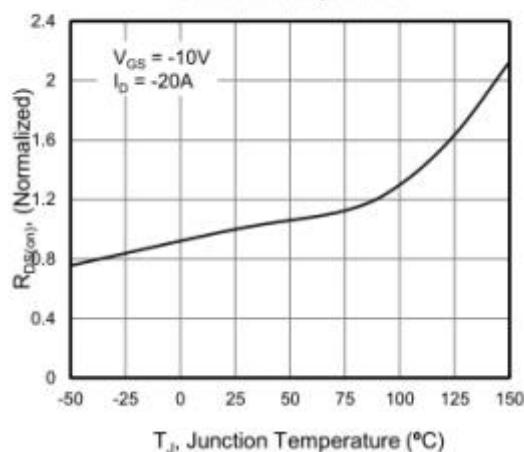


Figure 8. Threshold Voltage vs. Junction Temperature

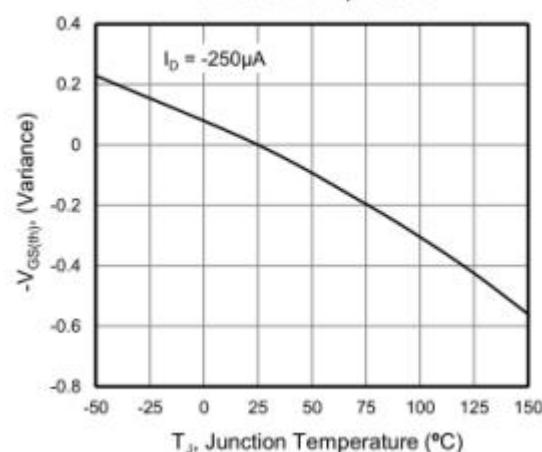


Figure 9. Transient Thermal Impedance

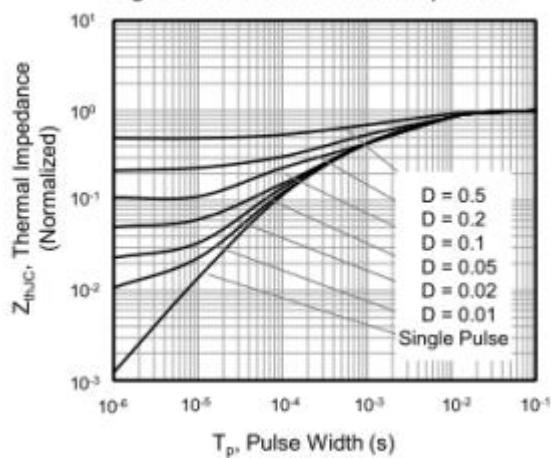
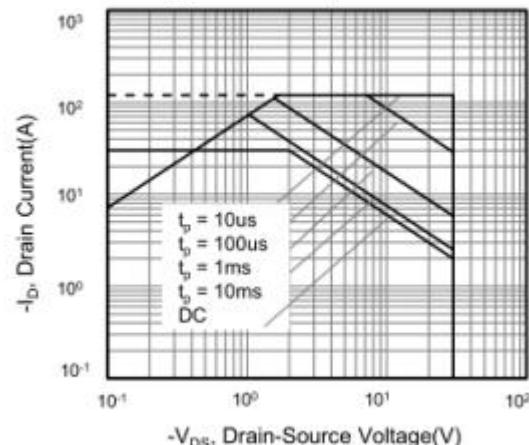
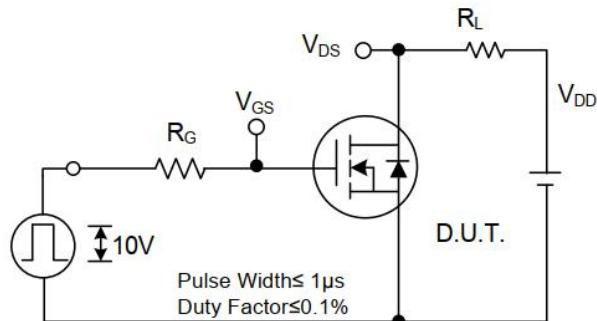


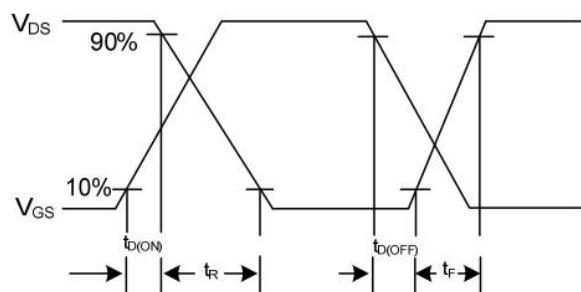
Figure 10. Safe operation area



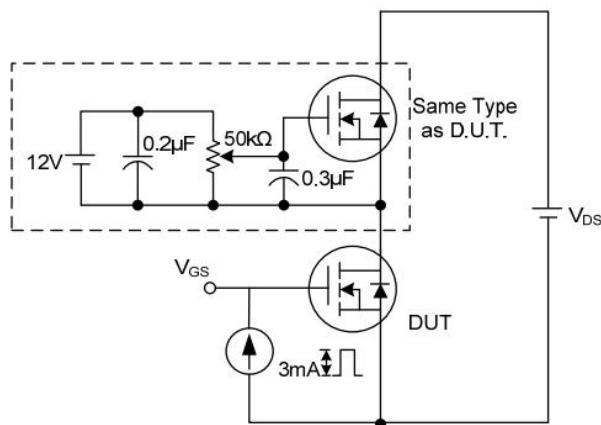
Test Circuits and Waveform



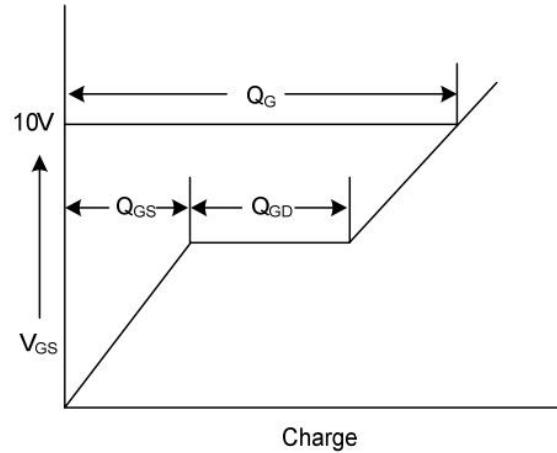
Switching Test Circuit



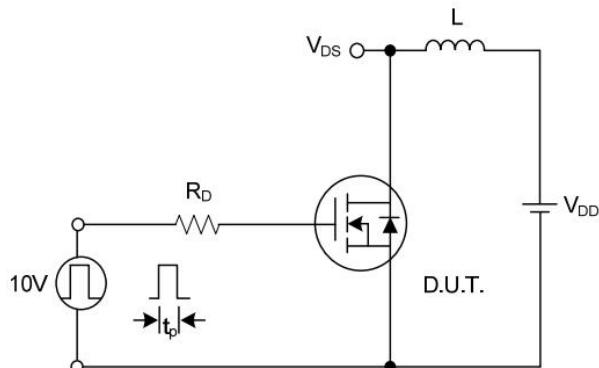
Switching Waveforms



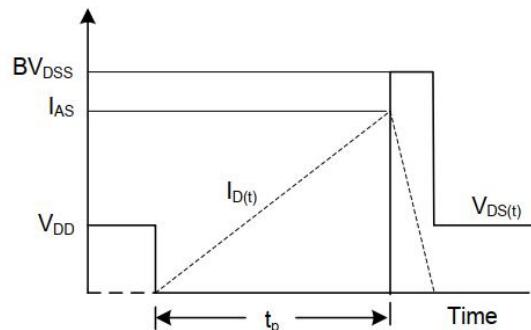
Gate Charge Test Circuit



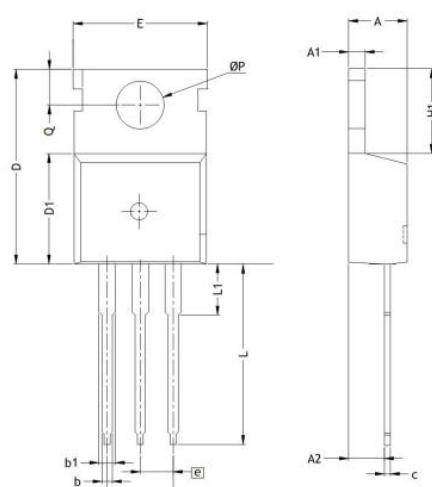
Gate Charge Waveform



Unclamped Inductive Switching Test Circuit

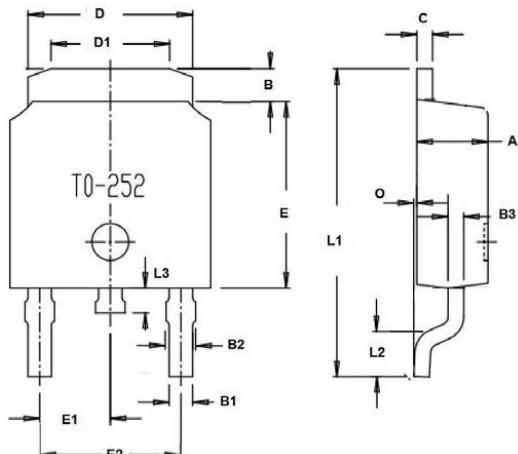


Unclamped Inductive Switching Waveforms

PACKAGE MECHANICAL DATA (Unit: mm):
TO-220CB


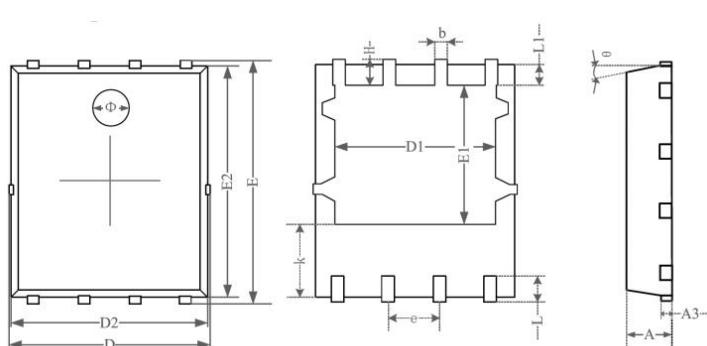
DIM	Min.	Max.
A	4.25	4.65
A1	1.25	1
A2	2.35	2
b	0.7	0
b1	1.15	1.75
c	0.45	0.6
D	14.35	15.9
D1	8.8	9
E	9.9	1
e	Typ 2.54	
e1	Typ 5.08	
H1	6.3	6.5
L	12.85	13.5
L1	2.85	3
Q	2.7	2.9
ØP	3.5	3.9

All Dimensions in millimeter

TO-252


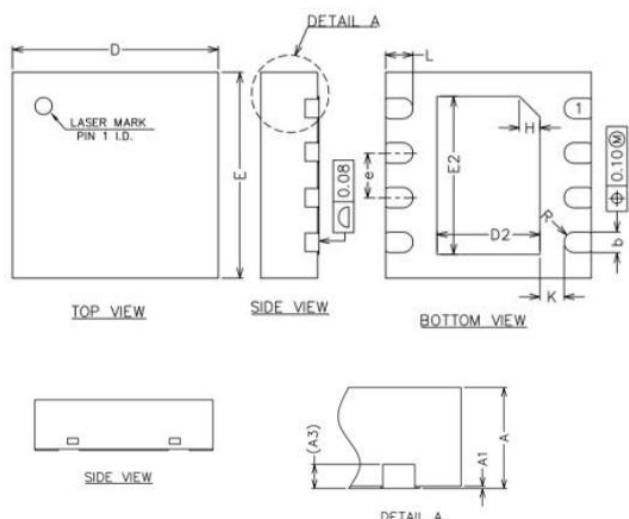
DIM	Min.	Max.
A	2.1	2.5
B	0.95	1.55
C	0.4	0.6
D	6.4	6.7
D1	5.1	5.8
E	5.8	6.4
E1	Typ 2.3	
E2	Typ 4.6	
B1	0.6	0.8
B2	0.75	0.95
O	--	0.15
L1	9.0	11.0
L2	1.3	1.7
L3	0.7	0.95

All Dimensions in millimeter

DFN5*6


DIM	Min.	Max.
A	0.8	1.0
A3	Typ 0.15	
D	4.9	5.1
E	6.0	6.1
D1	3.9	4.1
E1	3.3	3.5
D2	4.8	5.0
E2	5.7	5.8
K	1.2	1.4
b	0.3	0.4
e	Typ 1.27	
L	0.5	0.7
L1	0.4	0.6
H	0.5	0.7
θ	10°	12°
Ø	1.1	1.3

All Dimensions in millimeter

DFN3.3*3.3


DIM	Min.	Max.
A	0	0.9
A1	0	0.05
A3	Typ 0.20	
b	0	0.35
D	2	3.1
E	2	3.1
D2	1	1.6
E2	2	2.4
e	0	0.75
H	Typ 0.30	
K	0	0.45
L	0	0.45
R	0	---

All Dimensions in millimeter

Statement:

- ◆ We reserve the right to change the manual without prior notice! Customers should obtain the latest version of the information before placing an order, and verify that the relevant information is complete and up-to-date.
- ◆ Any semiconductor product has the possibility of failure or failure under specific conditions. The buyer has the responsibility to comply with safety standards and take safety measures when using Silan product for system design and complete machine manufacturing, so as to avoid the occurrence of personal injury or property loss caused by potential failure risk!
- ◆ Product promotion will never end, our company will wholeheartedly provide customers with more excellent products!